



**HIGH SPEED DUAL CHANNEL  
OPTICALLY COUPLED ISOLATOR  
PHOTOTRANSISTOR OUTPUT**

**APPROVALS**

- UL recognised, File No. E91231

**DESCRIPTION**

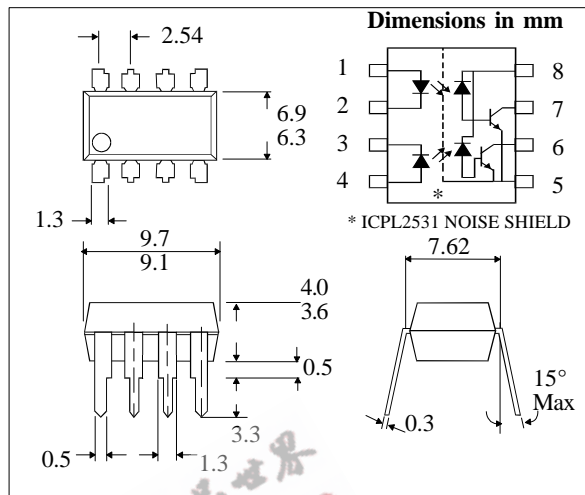
These dual channel diode-transistor optocouplers use a light emitting diode and an integrated photon detector to provide 2500Volts<sub>RMS</sub> electrical isolation between input and output. Separate connection for the photodiode bias and output transistor collector improve the speed up to a hundred times that of a conventional photo-transistor coupler by reducing the base-collector capacitance.

**FEATURES**

- High speed - 250k b/s NRZ
- High Common Mode Transient Immunity 1000V/μs
- TTL Compatible
- Open Collector Outputs
- 2500V<sub>RMS</sub> Withstand Test Voltage, 1 Min
- Options :-  
10mm lead spread - add G after part no.  
Surface mount - add SM after part no.  
Tape&reel - add SMT&R after part no.
- All electrical parameters 100% tested
- Custom electrical selections available

**APPLICATIONS**

- Line receivers
- Pulse transformer replacement
- Wide bandwidth analog coupling
- Output interface to CMOS-LSTTL-TTL



**ABSOLUTE MAXIMUM RATINGS  
(25°C unless otherwise specified)**

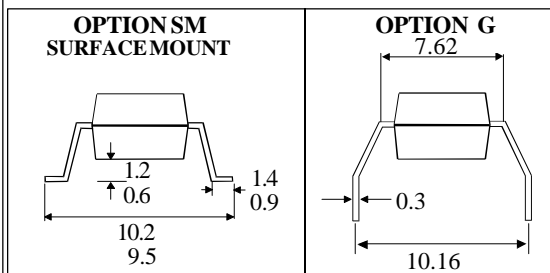
Storage Temperature \_\_\_\_\_ -55°C to + 125°C  
 Operating Temperature \_\_\_\_\_ -55°C to + 100°C  
 Lead Soldering Temperature  
 (1/16 inch (1.6mm) from case for 10 secs) 260°C

**INPUT DIODE**

Average Forward Current \_\_\_\_\_ 25mA ( 1 )  
 Peak Forward Current \_\_\_\_\_ 50mA ( 2 )  
 ( 50% duty cycle, 1ms pulse width )  
 Peak Transient Current \_\_\_\_\_ 1.0A  
 (equal to or less than 1μs P.W., 300 pps)  
 Reverse Voltage \_\_\_\_\_ 5V  
 Power Dissipation \_\_\_\_\_ 45mW( 3 )

**DETECTOR**

Average Output Current \_\_\_\_\_ 8mA  
 Peak Output Current \_\_\_\_\_ 16mA  
 Supply Voltage \_\_\_\_\_ -0.5 to +30V  
 Output Voltage \_\_\_\_\_ -0.5 to +20V  
 Power Dissipation \_\_\_\_\_ 35mW( 4 )



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**ELECTRICAL CHARACTERISTICS ( T<sub>A</sub> = 0°C to 70°C Unless otherwise noted )**

PARAMETER	SYM	DEVICE	MIN	TYP*	MAX	UNITS	TEST CONDITION
Current Transfer Ratio (note 5,6 )	CTR		15	21		%	I <sub>F</sub> = 8mA, V <sub>O</sub> = 0.5V, V <sub>CC</sub> = 4.5V, T <sub>A</sub> = 25°C
			12	19		%	I <sub>F</sub> = 16mA, V <sub>O</sub> = 0.5V, V <sub>CC</sub> = 4.5V, T <sub>A</sub> = 25°C
			11	14		%	I <sub>F</sub> = 8mA, V <sub>O</sub> = 0.5V, V <sub>CC</sub> = 4.5V
			9	12		%	I <sub>F</sub> = 16mA, V <sub>O</sub> = 0.5V, V <sub>CC</sub> = 4.5V
Logic Low Output Voltage (note 5 )	V <sub>OL</sub>			0.2	0.5	V	I <sub>F</sub> = 8mA, I <sub>O</sub> = 0.7mA, V <sub>CC</sub> = 4.5V
				0.2	0.5	V	I <sub>F</sub> = 16mA, I <sub>O</sub> = 1.1mA, V <sub>CC</sub> = 4.5V
Logic High Output Current (note 5 )	I <sub>OH</sub>			0.02	500	nA	I <sub>F1</sub> = I <sub>F2</sub> = 0mA, T <sub>A</sub> = 25°C, V <sub>O1</sub> = V <sub>O2</sub> = V <sub>CC</sub> = 5.5V
					50	μA	I <sub>F1</sub> = I <sub>F2</sub> = 0mA, V <sub>O1</sub> = V <sub>O2</sub> = V <sub>CC</sub> = 15V
Logic Low Supply Current	I <sub>CCL</sub>		40			μA	I <sub>F1</sub> = I <sub>F2</sub> = 8mA, V <sub>CC</sub> = 5.5V, V <sub>O1</sub> = V <sub>O2</sub> = open
			80			μA	I <sub>F1</sub> = I <sub>F2</sub> = 16mA, V <sub>CC</sub> = 5.5V, V <sub>O1</sub> = V <sub>O2</sub> = open
Logic High Supply Current	I <sub>CCH</sub>			0.05	4	μA	I <sub>F1</sub> = I <sub>F2</sub> = 0mA, V <sub>CC</sub> = 5.5V, V <sub>O1</sub> = V <sub>O2</sub> = open
Input Forward Voltage (note 5 )	V <sub>F</sub>			1.5	1.7	V	I <sub>F</sub> = 8mA, T <sub>A</sub> = 25°C
				1.5	1.7	V	I <sub>F</sub> = 16mA, T <sub>A</sub> = 25°C
Temperature Coefficient of Forward Voltage (note 5 )	$\frac{\Delta V_F}{\Delta T_A}$			-1.6		mV/°C	I <sub>F</sub> = 8mA
				-1.6		mV/°C	I <sub>F</sub> = 16mA
Input Reverse Voltage (note 5 )	V <sub>R</sub>		5			V	I <sub>R</sub> = 10μA, T <sub>A</sub> = 25°C
Input Capacitance (note 5 )	C <sub>IN</sub>			60		pF	f = 1MHz, V <sub>F</sub> = 0
Input-output Isolation Voltage (note 7)	V <sub>ISO</sub>		2500	5000		V <sub>RMS</sub>	R.H. equal to or less than 50%, t = 1min. T <sub>A</sub> = 25°C
Resistance (Input to Output)(note 7)	R <sub>I-O</sub>			10 <sup>12</sup>		Ω	V = 500V dc
Capacitance (Input to Output)(note 7)	C <sub>I-O</sub>					pF	f = 1MHz
	I <sub>I-I</sub>					μA	45 % Relative Humidity t = 5s, V = 500V dc
Resistance (Input to Input)(note 8)	R			10 <sup>11</sup>		Ω	V <sub>I-I</sub> = 500V dc
Capacitance (Input to Input)(note 8)	C <sub>I-I</sub>			0.25		pF	f = 1MHz

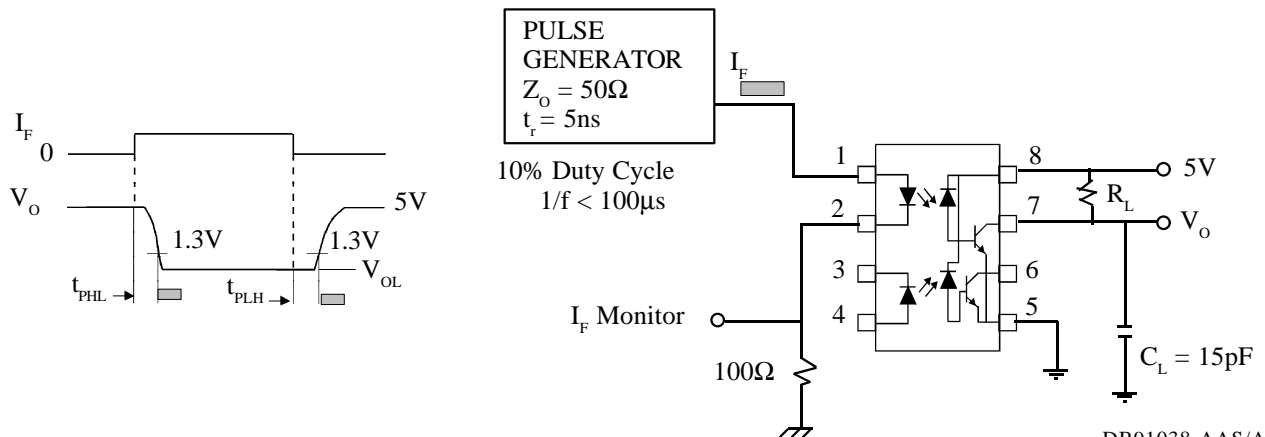
**SWITCHING SPECIFICATIONS AT  $T_A = 25^\circ\text{C}$  ( $V_{CC} = 5\text{V}$  Unless otherwise noted )**

PARAMETER	SYM	DEVICE	MIN	TYP	MAX	UNITS	TEST CONDITION
Propagation Delay Time to Logic Low at Output ( fig 1 )	$t_{PHL}$			0.8	1.5	$\mu\text{s}$	$I_F = 8\text{mA}, R_L = 7.5\text{k}\Omega$ (note 10)
				0.3	1.5	$\mu\text{s}$	$I_F = 16\text{mA}, R_L = 4.7\text{k}\Omega$ , (note11)
Propagation Delay Time to Logic High at Output ( fig 1 )	$t_{PLH}$			1.0	2.5	$\mu\text{s}$	$I_F = 8\text{mA}, R_L = 7.5\text{k}\Omega$ , (note 10)
				1.1	2.5	$\mu\text{s}$	$I_F = 16\text{mA}, R_L = 4.7\text{k}\Omega$ , (note11)
Common Mode Transient Immunity at Logic High Level Output ( fig 2 )	$CM_H$			1000		$\text{V}/\mu\text{s}$	$I_F = 0\text{mA}, V_{CM} = 10V_{PP}$ $R_L = 7.5\text{k}\Omega$ , (note9,10)
				1000		$\text{V}/\mu\text{s}$	$I_F = 0\text{mA}, V_{CM} = 10V_{PP}$ $R_L = 4.7\text{k}\Omega$ , (note9,11)
Common Mode Transient Immunity at Logic Low Level Output ( fig 2 )	$CM_L$			-1000		$\text{V}/\mu\text{s}$	$I_F = 8\text{mA}, V_{CM} = 10V_{PP}$ $R_L = 7.5\text{k}\Omega$ , (note9,10)
				-1000		$\text{V}/\mu\text{s}$	$I_F = 16\text{mA}, V_{CM} = 10V_{PP}$ $R_L = 1.9\text{k}\Omega$ , (note9,11)

**NOTES:-**

- Derate linearly above  $70^\circ\text{C}$  free air temperature at a rate of  $0.8 \text{ mA}/^\circ\text{C}$ .
- Derate linearly above  $70^\circ\text{C}$  free air temperature at a rate of  $1.6 \text{ mA}/^\circ\text{C}$ .
- Derate linearly above  $70^\circ\text{C}$  free air temperature at a rate of  $0.9 \text{ mW}/^\circ\text{C}$ .
- Derate linearly above  $70^\circ\text{C}$  free air temperature at a rate of  $1.0 \text{ mW}/^\circ\text{C}$ .
- Each channel.
- CURRENT TRANSFER RATIO is defined as the ratio of output collector current,  $I_O$ , to the forward LED input current,  $I_F$  times 100%.
- Device considered a two-terminal device: pins 1,2,3, and 4 shorted together and pins 5,6,7, and 8 shorted together.
- Measured between pins 1 and 2 shorted together, and pins 3 and 4 shorted together.
- Common mode transient immunity in Logic High level is the maximum tolerable (positive)  $dV_{CM}/dt$  on the leading edge of the common mode pulse  $V_{CM}$  to assure that the output will remain in a Logic High state (i.e.  $V_O > 2.0\text{V}$ ). Common mode transient immunity in Logic Low level is the maximum tolerable (negative)  $dV_{CM}/dt$  on the trailing edge of the common mode pulse signal,  $V_{CM}$  to assure that the output will remain in Logic Low state (i.e.  $V_O < 0.8\text{V}$ ).
- The  $7.5\text{k}\Omega$  load represents 1 LSTTL unit load of  $0.36\text{mA}$  and a  $20\text{k}\Omega$  pull-up resistor.
- The  $4.7\text{k}\Omega$  load represents 1 LSTTL unit load of  $0.36\text{mA}$  and a  $8.2\text{k}\Omega$  pull-up resistor.
- The  $2500 \text{ V}_{RMS} / 1\text{minute}$  capability is validated by a factory  $3.1\text{k} \text{ V}_{RMS} / 1\text{second}$  dielectric test.

**FIG.1 SWITCHING TEST CIRCUIT**



**FIG. 2 TEST CIRCUIT FOR TRANSIENT IMMUNITY AND TYPICAL WAVEFORMS**

